

Vishay Siliconix

Dual P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$r_{DS(on)}(\Omega)$ I_{C}			
- 20	0.015 at V _{GS} = - 4.5 V	- 9.4		
	0.019 at V _{GS} = - 2.5 V	- 8.4		
	0.024 at V _{GS} = - 1.8 V	- 7.5		

FEATURES

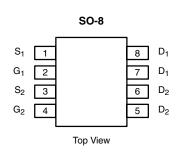
- TrenchFET® Power MOSFET
- Advanced High Cell Density Process



RoHS

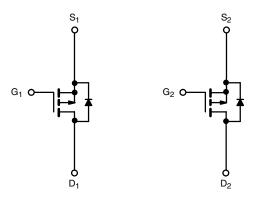
APPLICATIONS

· Load Switching



Ordering Information: Si4913DY-T1

Si4913DY-T1-E3 (Lead (Pb)-free)



P-Channel MOSFET

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$T_A = 25 ^{\circ}\text{C}$, unle	ess otherwise	noted		
Parameter		Symbol	10 sec	Steady State	Unit
Drain-Source Voltage		V _{DS}	- 20		V
Gate-Source Voltage		V _{GS}	± 8		
Opation - Desire Operat /T 450,00\8	T _A = 25 °C	I _D	- 9.4	- 7.1	^
Continuous Drain Current (T _J = 150 °C) ^a	T _A = 70 °C		- 7.5	- 5.7	
Pulsed Drain Current		I _{DM}	- 30		Α
Continuous Source Current (Diode Conduction) ^a		I _S	- 1.7	- 0.9	
Maximum Power Dissipation ^a	T _A = 25 °C	- P _D	2.0	1.1	W
	T _A = 70 °C		1.3	0.7	
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150		°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Manipulation to Application	t ≤ 10 sec	- R _{thJA}	45	62.5	°C/W	
Maximum Junction-to-Ambient ^a	Steady State		85	110		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	26	35		

Notes:

a. Surface Mounted on 1" x 1" FR4 Board.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply.

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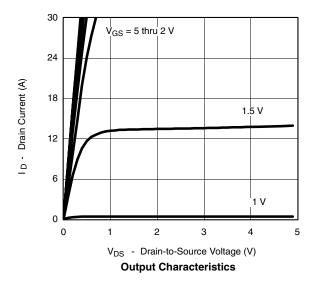
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
Static				•			
Gate Threshold Voltage V _{GS(th)}		$V_{DS} = V_{GS}, I_{D} = -500 \mu A$	- 0.40		- 1.0	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V			- 1		
		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 5	μΑ	
Dn-State Drain Current ^a $I_{D(on)}$ $V_{DS} = -5$		V _{DS} = - 5 V, V _{GS} = - 4.5 V	- 30			Α	
Drain-Source On-State Resistance ^a		V _{GS} = - 4.5 V, I _D = - 9.4 A		0.0125	0.015	Ω	
	r _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 8.4 A		0.0155	0.019		
		V _{GS} = - 1.8 V, I _D = - 3.0 A		0.020	0.024		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 9.4 A		40		S	
Diode Forward Voltage ^a	V_{SD}	I _S = - 1.7 A, V _{GS} = 0 V		- 0.7	- 1.2	V	
Dynamic ^b							
Total Gate Charge	Qg			43	65		
Gate-Source Charge	Q_{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -9.4 \text{ A}$		7.1		nC	
Gate-Drain Charge	Q_{gd}			10.9		1	
Turn-On Delay Time	t _{d(on)}			32	50		
Rise Time	t _r	V_{DD} = 10 V, R_L = 10 Ω		42	65		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 1 A, V_GEN = - 4.5 V, R_G = 6 Ω		350	525	ns	
Fall Time	t _f			160	240		
Source-Drain Reverse Recovery Time	t _{rr}	I _F = - 1.7 A, di/dt = 100 A/μs		127	200		

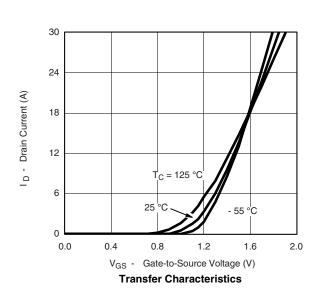
Notes:

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C unless noted



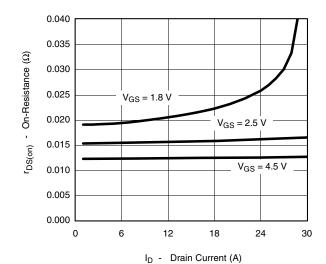




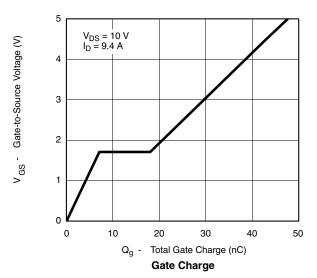


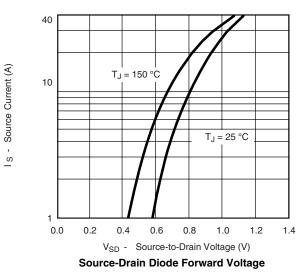


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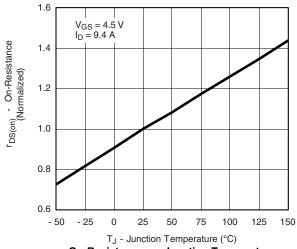
On-Resistance vs. Drain Current



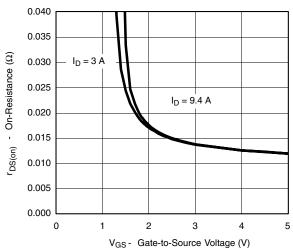


 $V_{DS}\,$ - Drain-to-Source V oltage (V)





On-Resistance vs. Junction Temperature

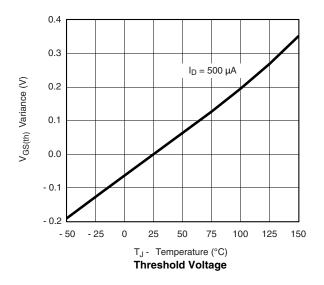


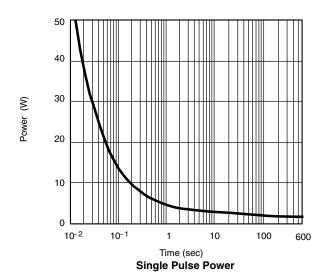
On-Resistance vs. Gate-to-Source Voltage

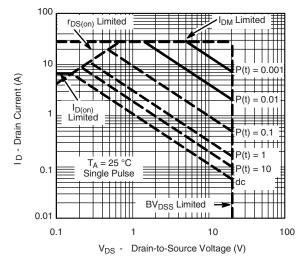
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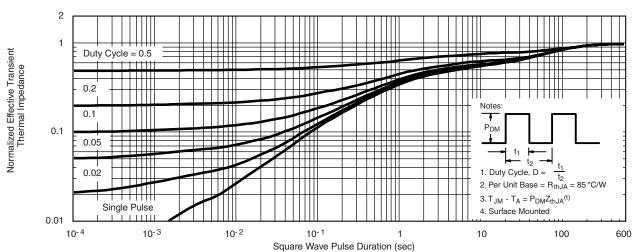
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Safe Operating Area, Junction-to-Ambient

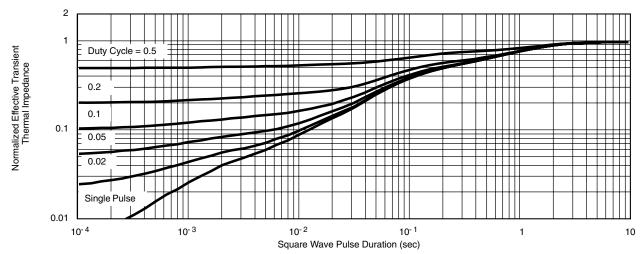


Normalized Thermal Transient Impedance, Junction-to-Ambient





TYPICAL CHARACTERISTICS 25 °C unless noted



Normalized Thermal Transient Impedance, Junction-to-Foot

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